

ISL9V3036D3S / ISL9V3036S3S / ISL9V3036P3

EcoSPARK® 300mJ, 360V, N-Channel Ignition IGBT

General Description

The ISL9V3036D3S, ISL9V3036S3S, and ISL9V3036P3 are the next generation IGBTs that offer outstanding SCIS capability in the space saving D-Pak (TO-252), as well as the industry standard D²-Pak (TO-263) and TO-220 plastic packages. These devices are intended for use in automotive ignition circuits, specifically as a coil drivers. Internal diodes provide voltage clamping without the need for external components.

EcoSPARK® devices can be custom made to specific clamp voltages. Contact your nearest Fairchild sales office for more information.

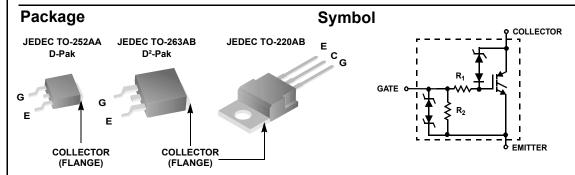
Formerly Developmental Type 49442

Applications

- · Automotive Ignition Coil Driver Circuits
- · Coil- On Plug Applications

Features

- Industry Standard D²-Pak package
- SCIS Energy = 300mJ at T_J = 25°C
- · Logic Level Gate Drive



Device Maximum Ratings T_{.i} = 25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
BV _{CER}	Collector to Emitter Breakdown Voltage (I _C = 1 mA)	360	V
BV _{ECS}	Emitter to Collector Voltage - Reverse Battery Condition (I _C = 10 mA)	24	V
E _{SCIS25}	$T_J = 25$ °C, $I_{SCIS} = 14.2A$, $L = 3.0$ mHy	300	mJ
E _{SCIS150}	$T_J = 150$ °C, $I_{SCIS} = 10.6$ A, L = 3.0 mHy	170	mJ
I _{C25}	Collector Current Continuous, At T _C = 25°C, See Fig 9	21	Α
I _{C110}	Collector Current Continuous, At T _C = 110°C, See Fig 9	17	Α
V_{GEM}	Gate to Emitter Voltage Continuous	±10	V
P_{D}	Power Dissipation Total T _C = 25°C	150	W
	Power Dissipation Derating T _C > 25°C	1.0	W/°C
TJ	Operating Junction Temperature Range	-40 to 175	°C
T _{STG}	Storage Junction Temperature Range -40 to 175		°C
TL	Max Lead Temp for Soldering (Leads at 1.6mm from Case for 10s)	300	°C
T _{pkq}	Max Lead Temp for Soldering (Package Body for 10s)	260	°C
ESD	Electrostatic Discharge Voltage at 100pF, 1500Ω 4		

V3036D										
)	ISL9V3036D3ST	TO-252AA	330mm		16mm			2500	
V3036S ISL9V3036S3ST TO-2		TO-263AB	330mm		24mm			800		
V3036P		ISL9V3036P3	TO-220AA	Tube		N/A			50	
V3036D		ISL9V3036D3S	TO-252AA	Tube		N/A			75	
V3036S ISL9V3036S3S TO-263AB			Tube		N/A			50		
	al C	haracteristic		1	T		Τ _		1	
Symbol		Paramet	er	Test Conditions		Min	Тур	Max	Units	
Off State	Char	acteristics								
BV _{CER}	Colle	ector to Emitter Brea	$I_C = 2\text{mA}, V_{GE} = 0,$ $R_G = 1\text{K}\Omega, \text{ See Fig. 15}$ $T_J = -40 \text{ to } 150^{\circ}\text{C}$		330	360	390	V		
BV _{CES}	Colle	ector to Emitter Brea	I _C = 10mA, V _{GE} = 0, R _G = 0, See Fig. 15 T _J = -40 to 150°C		350	380	410	V		
BV _{ECS}	Emit	ter to Collector Brea	akdown Voltage	$I_C = -75 \text{mA}, V_{GE} = 0 \text{V},$ $T_C = 25 ^{\circ}\text{C}$		30	-	-	V	
BV _{GES}	Gate	to Emitter Breakdo	$I_{GES} = \pm 2mA$		±12	±14	-	V		
I _{CER}	_	Collector to Emitter Leakage Current		V _{CER} = 250V,	T _C = 25°C	-	-	25	μΑ	
				$R_G = 1K\Omega$, See Fig. 11	T _C = 150°C	-	1	1	mA	
I _{ECS}	Emit	ter to Collector Leal	kage Current	V _{EC} = 24V, See	$T_C = 25^{\circ}C$	-	-	1	mA	
				Fig. 11	T _C = 150°C	-	-	40	mA	
R ₁	Seri	es Gate Resistance			-	70	-	Ω		
R ₂	Gate	to Emitter Resistar	nce			10K	-	26K	Ω	
On State (Char	acteristics								
$V_{CE(SAT)}$	Colle	ollector to Emitter Saturation Voltage		I _C = 6A, V _{GE} = 4V	T _C = 25°C, See Fig. 3	-	1.25	1.60	V	
$V_{CE(SAT)}$	Colle	ollector to Emitter Saturation Voltage		I _C = 10A, V _{GE} = 4.5V	T _C = 150°C, See Fig. 4	-	1.58	1.80	V	
$V_{CE(SAT)}$	Colle	ector to Emitter Satu	ıration Voltage	I _C = 15A, V _{GE} = 4.5V	T _C = 150°C	-	1.90	2.20	V	
) Dynamic	Char	acteristics								
Q _{G(ON)}	Gate	e Charge	$I_{C} = 10A, V_{CE} = V_{GE} = 5V, See$		-	17	-	nC		
V _{GE(TH)}	Gate	e to Emitter Thresho	old Voltage	I _C = 1.0mA,	T _C = 25°C	1.3	-	2.2	V	
				V _{CE} = V _{GE,} See Fig. 10	T _C = 150°C	0.75	-	1.8	٧	
V_{GEP}	Gate	e to Emitter Plateau	Voltage	I _C = 10A,	V _{CE} = 12V	-	3.0	-	V	
witching	Cha	racteristics								
$t_{d(ON)R}$	Curr	ent Turn-On Delay	$V_{CE} = 14V, R_{L} = 1\Omega,$		-	0.7	4	μs		
t _{rR}		ent Rise Time-Resi	V_{GE} = 5V, R_{G} = 1K Ω T_{J} = 25°C, See Fig. 12		-	2.1	7	μs		
t _{d(OFF)L}		Current Turn-Off Delay Time-Inductive		$V_{CE} = 300V, R_{L} = 500\mu H,$		-	4.8	15	μs	
t _{fL}		ent Fall Time-Induc	$V_{GE} = 5V$, $R_G = 1K\Omega$ $T_J = 25^{\circ}C$, See Fig. 12		-	2.8	15	μs		
SCIS	Self	Clamped Inductive	$T_J = 25$ °C, L = 3 $R_G = 1$ K Ω , V_{GE}		-	-	300	mJ		
hermal (har	acteristics								

Typical Performance Curves

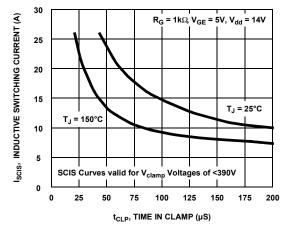


Figure 1. Self Clamped Inductive Switching Current vs Time in Clamp

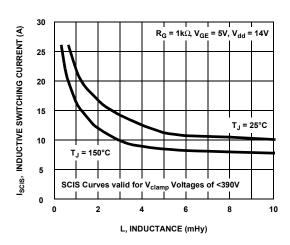


Figure 2. Self Clamped Inductive Switching Current vs Inductance

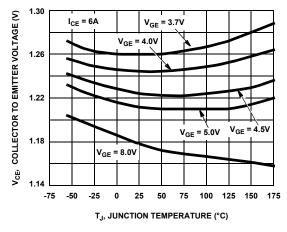


Figure 3. Collector to Emitter On-State Voltage vs Junction Temperature

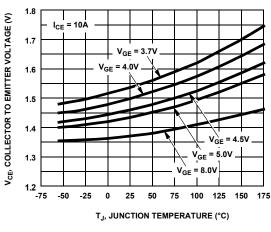


Figure 4. Collector to Emitter On-State Voltage vs Junction Temperature

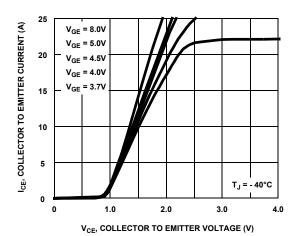


Figure 5. Collector to Emitter On-State Voltage vs Collector Current

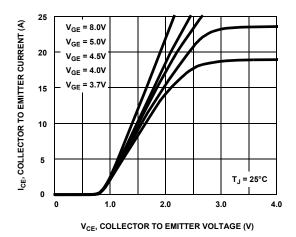
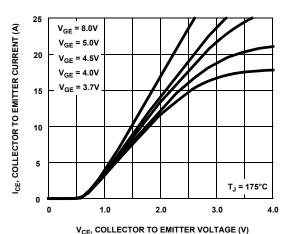
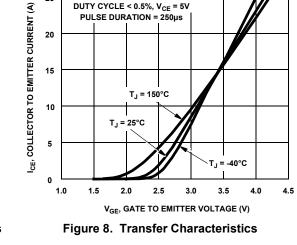


Figure 6. Collector to Emitter On-State Voltage vs Collector Current



Typical Performance Curves (Continued)

Figure 7. Collector to Emitter On-State Voltage vs **Collector Current**



DUTY CYCLE < 0.5%, V_{CE} = 5V

25

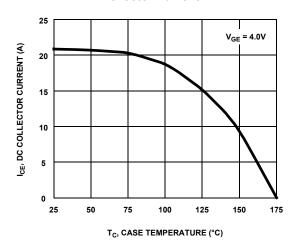


Figure 9. DC Collector Current vs Case **Temperature**

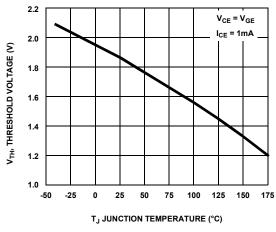


Figure 10. Threshold Voltage vs Junction **Temperature**

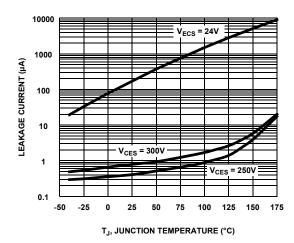


Figure 11. Leakage Current vs Junction **Temperature**

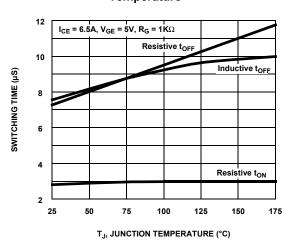


Figure 12. Switching Time vs Junction **Temperature**

Typical Performance Curves (Continued) FREQUENCY = 1 MHz Columbia Columbi

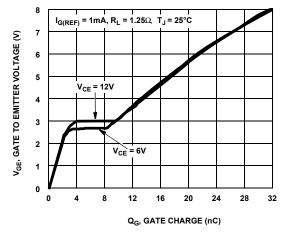


Figure 13. Capacitance vs Collector to Emitter Voltage

V_{CE}, COLLECTOR TO EMITTER VOLTAGE (V)

10

15

20

0

Figure 14. Gate Charge

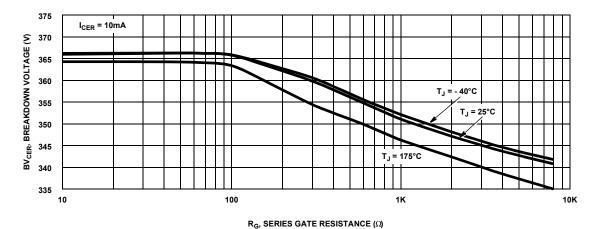


Figure 15. Breakdown Voltage vs Series Gate Resistance

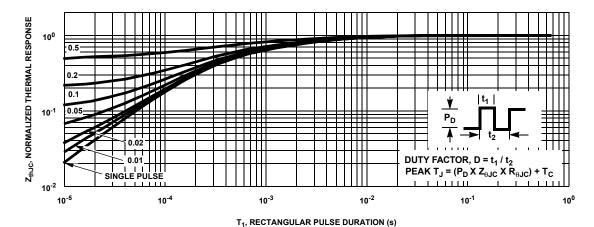
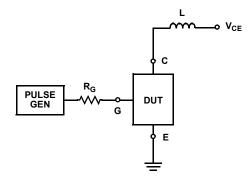


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

Test Circuit and Waveforms



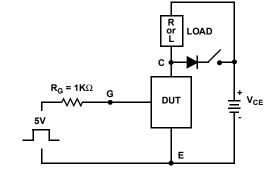
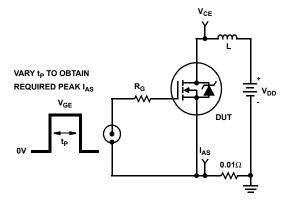


Figure 17. Inductive Switching Test Circuit

Figure 18. $t_{\rm ON}$ and $t_{\rm OFF}$ Switching Test Circuit

BV_{CES}



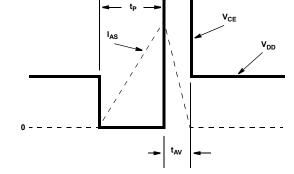


Figure 19. Unclamped Energy Test Circuit

Figure 20. Unclamped Energy Waveforms

SPICE Thermal Model JUNCTION **REV 24 April 2002** ISL9V3036D3S/ ISL9V3036S3S / ISL9V3036P3 CTHERM1 th 6 2.1e -3 CTHERM2 6 5 1.4e -1 RTHERM1 CTHERM1 CTHERM3 5 4 7.3e -3 CTHERM4 4 3 2.1e -1 CTHERM5 3 2 1.1e -1 CTHERM6 2 tl 6.2e +6 6 RTHERM1 th 6 1.2e -1 RTHERM2 6 5 1.9e -1 RTHERM2 CTHERM2 RTHERM3 5 4 2.2e -1 RTHERM4 4 3 6.0e -2 RTHERM5 3 2 5.8e -2 RTHERM6 2 tl 1.6e -3 5 SABER Thermal Model RTHERM3 CTHERM3 SABER thermal model ISL9V3036D3S / ISL9V3036S3S / ISL9V3036P3 template thermal_model th tl thermal_c th, tl ctherm.ctherm1 th 6 = 2.1e - 3ctherm.ctherm2 6 5 = 1.4e -1 ctherm.ctherm3 5 4 = 7.3e -3 RTHERM4 CTHERM4 ctherm.ctherm4 4 3 = 2.2e -1 ctherm.ctherm5 3 2 =1.1e -1 ctherm.ctherm6 2 tl = 6.2e +6 3 rtherm.rtherm1 th 6 = 1.2e -1 rtherm.rtherm2 6 5 = 1.9e -1 rtherm.rtherm3 5 4 = 2.2e -1 RTHERM5 CTHERM5 rtherm.rtherm4 4 3 = 6.0e -2 rtherm.rtherm5 3 2 = 5.8e -2 rtherm.rtherm6 2 tl = 1.6e -3 2 RTHERM6 CTHERM6 CASE





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Definition of Torms

Deminition of Terms				
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